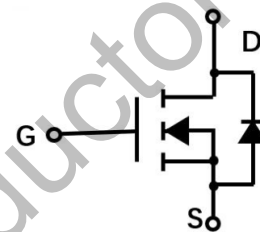


Features

- 100V, 50A
- $R_{DS(ON)} = 18m\Omega$ (Max.) @ $V_{GS} = 10V$, $I_D = 20A$
- Low $R_{DS(on)}$ & FOM
- Extremely low switching loss
- Excellent stability and uniformity
- 100% UIS tested , 100% ΔV_{DS} Tested
- RoHS and Halogen-Free Compliant

Application

- High Frequency Switching
- Synchronous Rectification



Absolute Maximum Ratings $T_C=25^\circ C$ unless otherwise specified

Symbol	Parameter		Max.	Units
V_{DSS}	Drain-Source Voltage		100	V
V_{GSS}	Gate-Source Voltage		± 20	V
I_D	Continuous Drain Current ^{note5}	$T_C = 25^\circ C$	50	A
I_D	Continuous Drain Current ^{note5}	$T_C = 100^\circ C$	31.5	A
I_{DM}	Pulsed Drain Current ^{note3}		200	A
P_D	Power Dissipation ^{note2}	$T_C = 25^\circ C$	68	W
I_{AS}	Avalanche Current ^{note3,6}		21	A
E_{AS}	Single Pulse Avalanche Energy ^{note3,6}		110	mJ
$R_{\theta JC}$	Thermal Resistance, Junction to Case		1.85	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ^{note1,4}		55	$^\circ C/W$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ C$

*Drain current limited by maximum junction temperature

Electrical Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
Off Characteristic						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250μA	100	-	-	V
I _{DSS}	Drain-Source Leakage Current	V _{DS} = 80V, V _{GS} = 0V	-	-	1	μA
I _{GSS}	Gate to Body Leakage Current	V _{DS} = 0V, V _{GS} = ±20V	-	-	±100	nA
On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	1.2	1.8	2.5	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 20A	-	15	18	mΩ
		V _{GS} = 4.5V, I _D = 10A	-	19.5	25	mΩ
R _g	Gate Resistance	V _{DS} = V _{GS} =0V, f = 1.0MHz	-	1.49	-	Ω
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 50V, V _{GS} = 0V, f = 1.0MHz	-	1004	-	pF
C _{oss}	Output Capacitance		-	186	-	pF
C _{rss}	Reverse Transfer Capacitance		-	6.5	-	pF
Switching Characteristics						
Q _g	Total Gate Charge	V _{DS} = 50V, I _D = 40A, V _{GS} = 10V	-	26.1	-	nC
Q _{gs}	Gate-Source Charge		-	8.0	-	
Q _{gd}	Gate-Drain(“Miller”) Charge		-	3.3	-	
t _{d(on)}	Turn-On Delay Time	V _{DS} = 50V, I _D = 20A, R _G = 3Ω, V _{GS} =10V	-	5.4	-	ns
t _r	Turn-On Rise Time		-	2.9	-	
t _{d(off)}	Turn-Off Delay Time		-	10.8	-	
t _f	Turn-Off Fall Time		-	2.1	-	
Diode Characteristics						
I _S	Continuous Source Current		-	-	50	A
V _{SD}	Diode Forward Voltage	I _S =20A . V _{GS} = 0V	-	0.88	1.0	V
t _{rr}	Reverse Recovery Time	I _{SD} =20A,	-	34	-	ns
Q _{rr}	Reverse Recovery Charge	dl _{SD} /dt=100A/μs	-	35	-	nC

Notes:

1. The value of $R_{\theta JC}$ is measured in a still air environment with $T_A = 25^{\circ}\text{C}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.
2. The power dissipation P_D is based on $T_{J(MAX)}=150^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
3. Single pulse width limited by junction temperature $T_{J(MAX)}=150^{\circ}\text{C}$.
4. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
5. The maximum current rating is package limited.
6. The EAS data shows Max. rating. The test condition is $V_{DS}=50V, V_{GS}=10V, L=0.5mH$

Typical Performance Characteristics

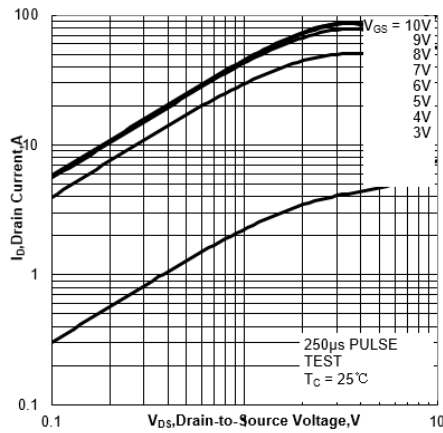


Figure 1. Output Characteristics

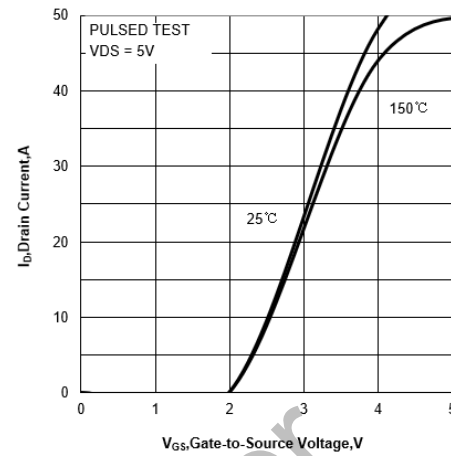


Figure 2. Transfer Characteristics

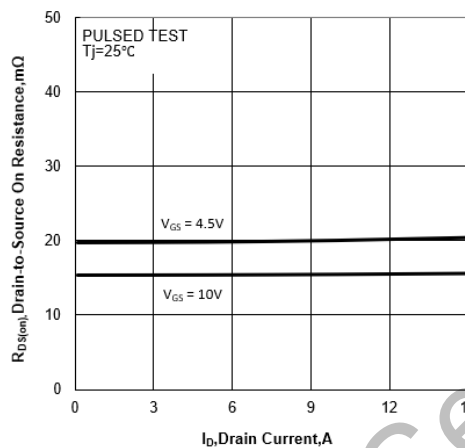


Figure 3. Drain-to-Source On Resistance vs Drain Current

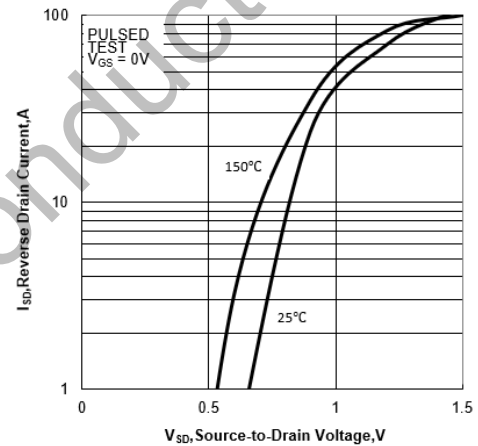


Figure 4. Body Diode Forward Voltage vs Source Current and Temperature

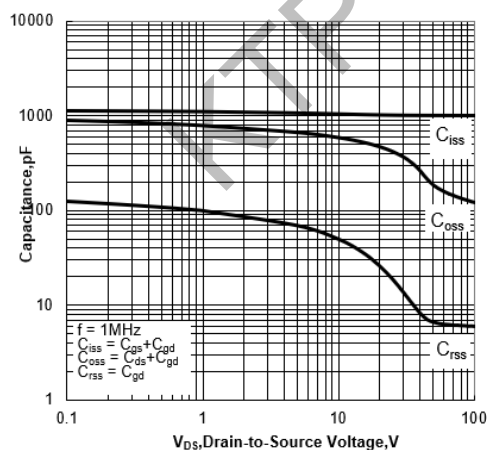


Figure 5. Capacitance Characteristics

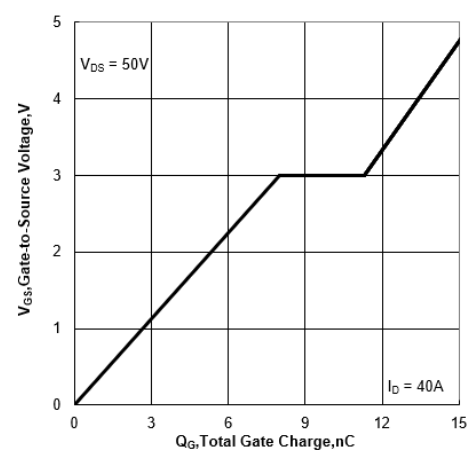


Figure 6. Gate Charge Characteristics

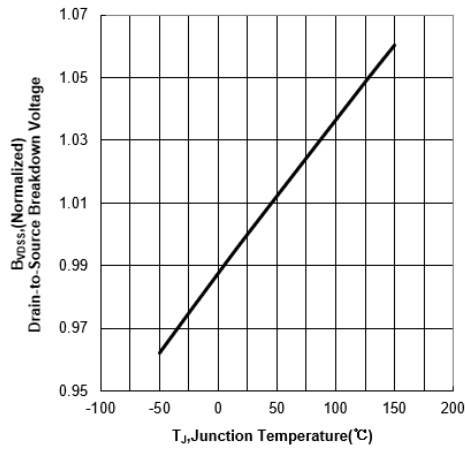


Figure 7. Normalized Breakdown Voltage vs Junction Temperature

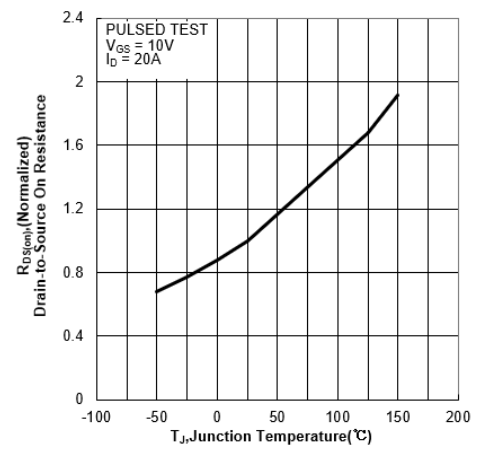


Figure 8. Normalized On Resistance vs Junction Temperature

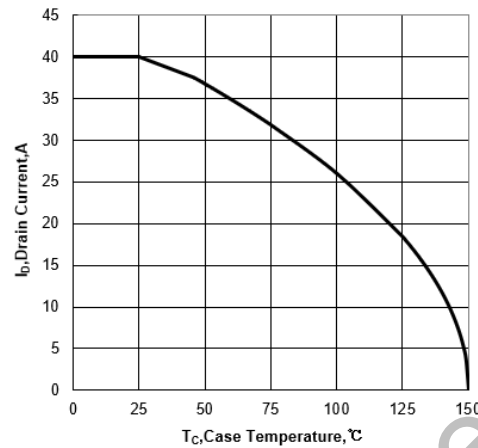


Figure 9. Maximum Continuous Drain Current vs Case Temperature

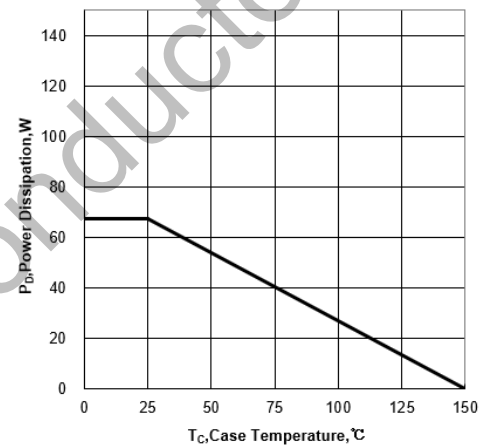


Figure 10. Maximum Power Dissipation vs Case Temperature

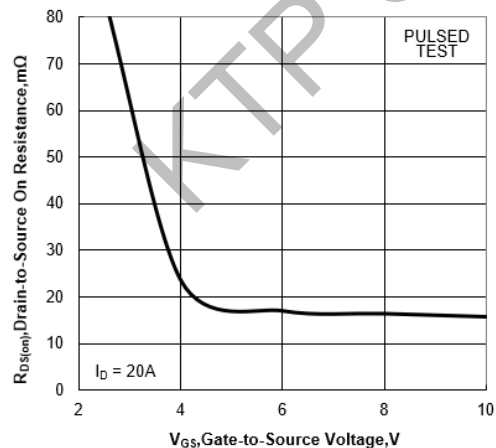


Figure 11. Drain-to-Source On Resistance vs Gate Voltage and Drain Current

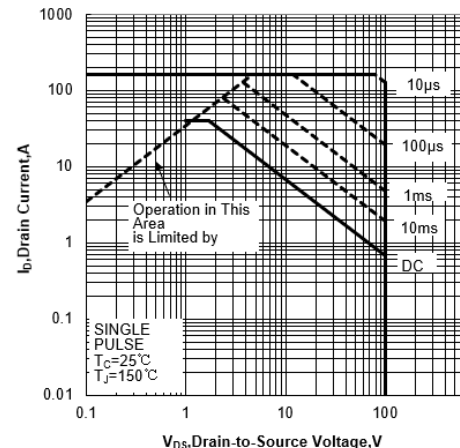


Figure 12. Maximum Safe Operating Area

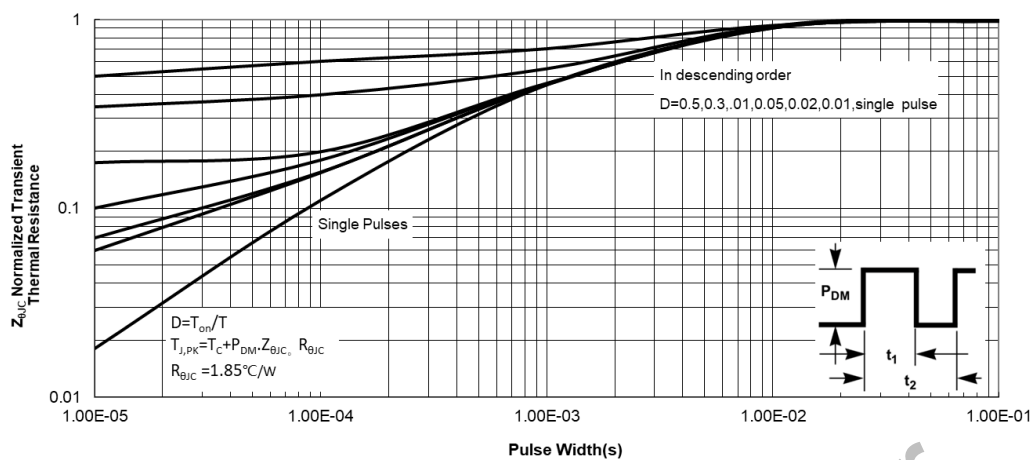
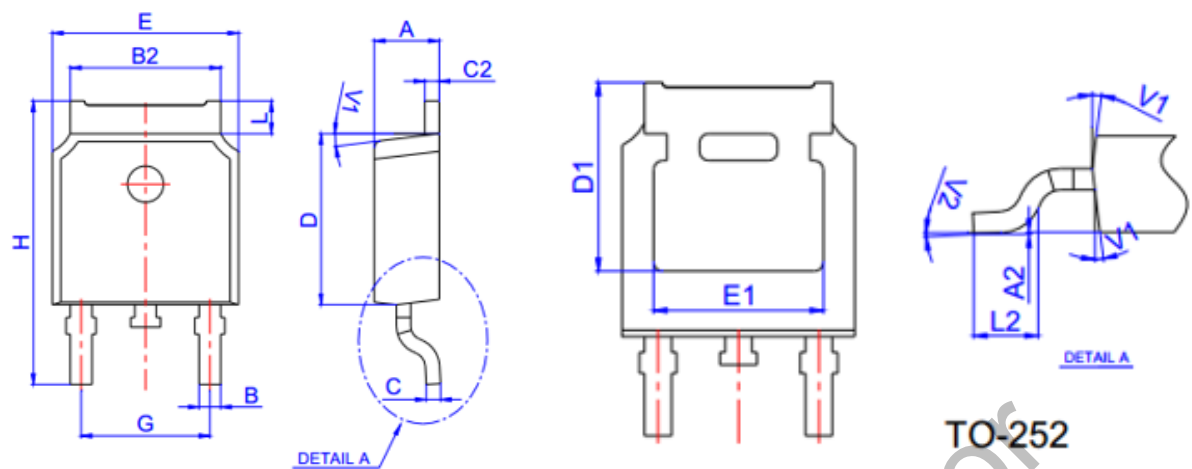


Figure 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

TO-252-3L Package Mechanical Data



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	2.10		2.50	0.083		0.098
A2	0		0.10	0		0.004
B	0.66		0.86	0.026		0.034
B2	5.18		5.48	0.202		0.216
C	0.40		0.60	0.016		0.024
C2	0.44		0.58	0.017		0.023
D	5.90		6.30	0.232		0.248
D1	5.30REF			0.209REF		
E	6.40		6.80	0.252		0.268
E1	4.63			0.182		
G	4.47		4.67	0.176		0.184
H	9.50		10.70	0.374		0.421
L	1.09		1.21	0.043		0.048
L2	1.35		1.65	0.053		0.065
V1		7°			7°	
V2	0°		6°	0°		6°